



## FQB11N40C/FQI11N40C

#### **400V N-Channel MOSFET**

#### **General Description**

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction, electronic lamp ballasts based on half bridge topology.

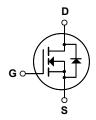
#### **Features**

- 10.5 A, 400V,  $R_{DS(on)}$  = 0.5  $\Omega$  @V<sub>GS</sub> = 10 V Low gate charge ( typical 28 nC)
- Low Crss (typical 85pF)
- Fast switching
- · 100% avalanche tested
- · Improved dv/dt capability
- · RoHS Compliant









## Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQB11N40C / FQI11N40C	Units
V <sub>DSS</sub>	Drain-Source Voltage		400	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C	)	10.5	Α
	- Continuous (T <sub>C</sub> = 100°C)		6.6	Α
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	42	Α
V <sub>GSS</sub>	Gate-Source Voltage		± 30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	360	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	11	Α
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	13.5	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
$P_{D}$	Power Dissipation (T <sub>C</sub> = 25°C)		135	W
	- Derate above 25°C		1.07	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
T <sub>L</sub>	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

### **Thermal Characteristics**

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	-	0.93	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *	-	40	°C/W
$R_{\theta JA}$	R <sub>0JA</sub> Thermal Resistance, Junction-to-Ambient		62.5	°C/W

\* When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	racteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA				V
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, Referenced to 25°C		0.54		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V			1	μΑ
		V <sub>DS</sub> = 320 V, T <sub>C</sub> = 125°C			10	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V			-100	nA
On Cha	racteristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	2.0		4.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 5.25 A		0.5	0.53	Ω
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 40 V, I <sub>D</sub> = 5.25 A (Note 4)		7.1		S
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$		840	1090	pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz		250	325	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	†		85	110	pF
Switchi	ng Characteristics					
t <sub>d(on)</sub>	Turn-On Delay Time	V - 200 V I - 40 5 A		14	40	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD} = 200 \text{ V}, I_{D} = 10.5 \text{ A},$ $R_{G} = 25 \Omega$		89	190	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	NG - 25 12		81	170	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4, 5)		81	170	ns
Qg	Total Gate Charge	V <sub>DS</sub> = 320 V, I <sub>D</sub> = 10.5 A,		28	35	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 10 V		4		nC
Q <sub>gd</sub>	Gate-Drain Charge	(Note 4, 5)		15		nC
Drain-S	ource Diode Characteristics a	nd Maximum Ratings		15		
l <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current				10.5	Α
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode F				42	Α
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 10.5 A			1.4	V
t <sub>rr</sub>	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_S = 10.5 \text{ A},$		290		ns
$Q_{rr}$	Reverse Recovery Charge	$dI_F / dt = 100 A/\mu s$ (Note 4)		2.4		μC

- Notes: 
  1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 5.7 mH, I<sub>AS</sub> = 10.5A, V<sub>DD</sub> = 50V, R<sub>G</sub> = 25 Ω, Starting T<sub>J</sub> = 25°C 3. I<sub>SD</sub> ≤ 10.5A, di/dt ≤ 200A/μs, V<sub>DD</sub> ≤ BV<sub>DSS</sub>, Starting T<sub>J</sub> = 25°C 4. Pulse Test : Pulse width ≤ 300μs, Duty cycle ≤ 2% 5. Essentially independent of operating temperature

## **Typical Characteristics**

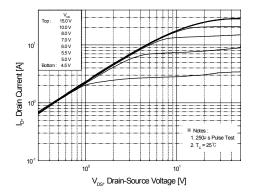


Figure 1. On-Region Characteristics

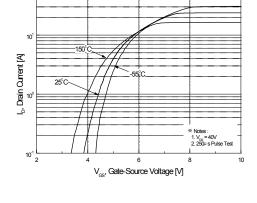


Figure 2. Transfer Characteristics

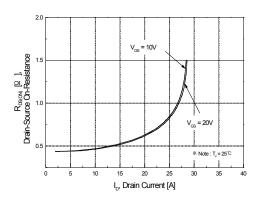


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

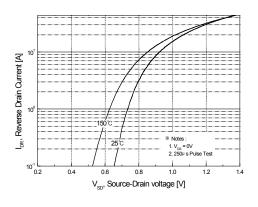


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

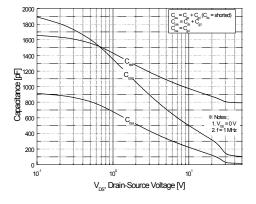


Figure 5. Capacitance Characteristics

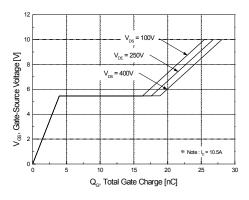
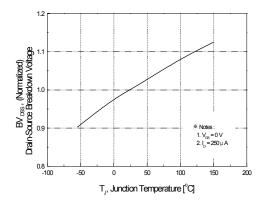


Figure 6. Gate Charge Characteristics

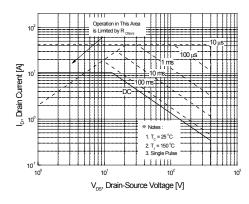
## Typical Characteristics (Continued)



2.5
(Rez. injection Temperature [°C]

Figure 7. Breakdown Voltage Variation vs Temperature

Figure 8. On-Resistance Variation vs Temperature



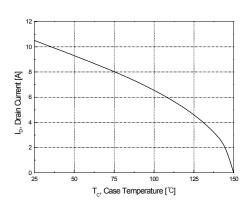


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs Case Temperature

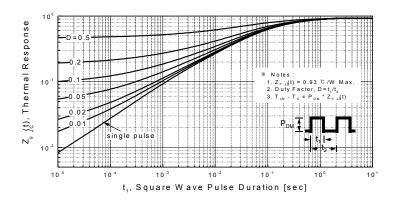
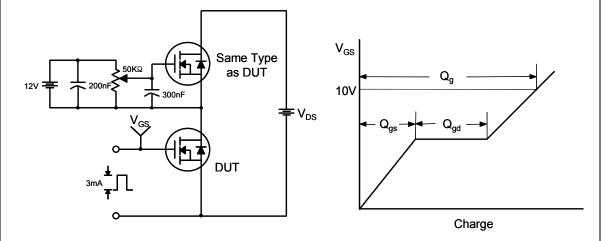
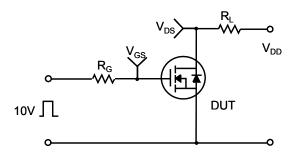


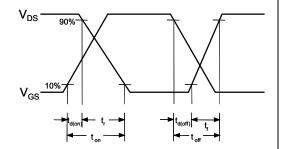
Figure 11. Transient Thermal Response Curve

## **Gate Charge Test Circuit & Waveform**

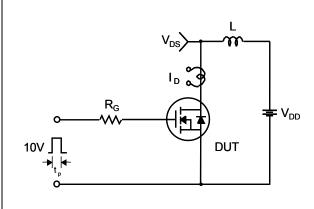


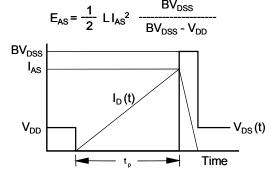
#### **Resistive Switching Test Circuit & Waveforms**



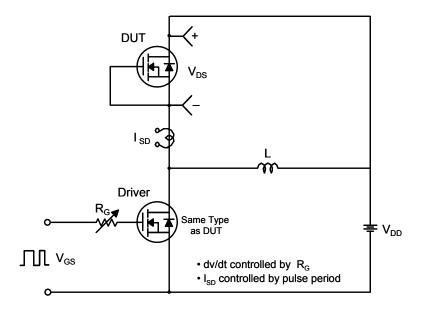


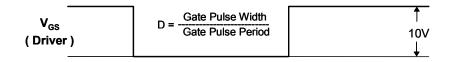
## **Unclamped Inductive Switching Test Circuit & Waveforms**

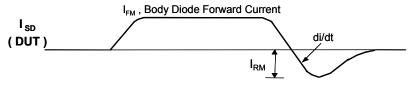




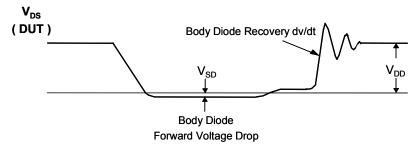
#### Peak Diode Recovery dv/dt Test Circuit & Waveforms







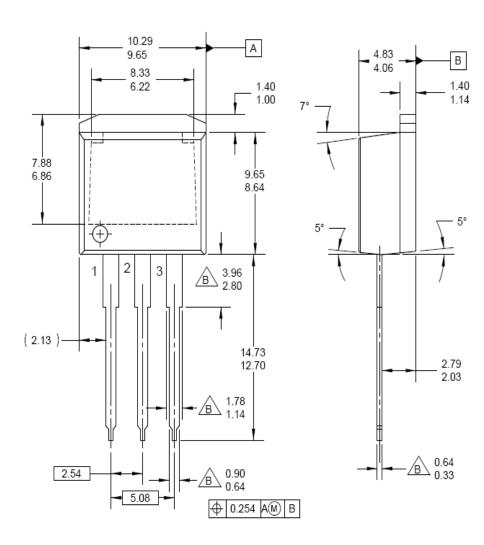
Body Diode Reverse Current



# **Mechanical Dimensions** D<sup>2</sup> - PAK -A-10.67 9.65 9.50 MIN 9.00 MIN 1.78 MAX 10.00 (2.12)→ -1.50 MIN → 0.25 M B AM 5.08 5.08 -LAND PATTERN RECOMMENDATION -B-4.83 4.06 -6.22 MIN --1.65 1.14 6.86 MIN 15.88 14.61 SEE DETAIL A GAGE PLANE 0.25 △ 0.10 B .25 MAX -SEATING PLANE **DETAIL** Dimensions in Millimeters

#### **Mechanical Dimensions**

I<sup>2</sup> - PAK



Dimensions in Millimeters





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